

# FMNN3400-H

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# FMNN3400-H

## 5.2A 30V N-Channel Enhancement Mode Power MOSFET

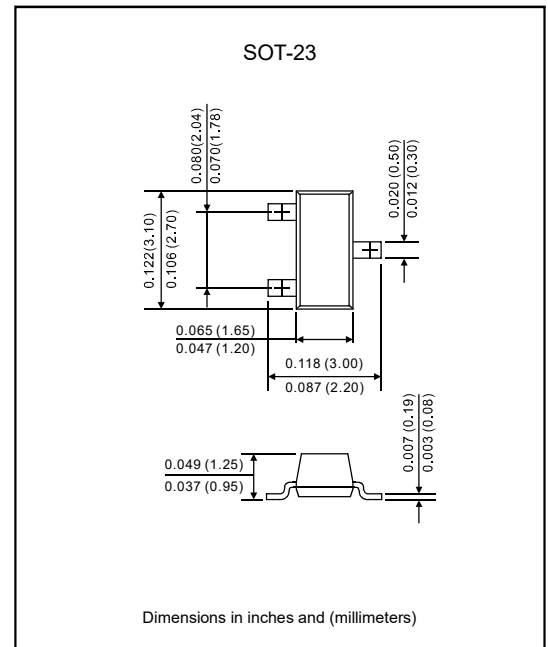
### Features

- $V_{DS}=30V, I_D=5.2A$ .
- $R_{DS(ON)} \leq 32\text{ m}\Omega, @V_{GS}=10V, I_D=5.2A$ .
- $R_{DS(ON)} \leq 38\text{ m}\Omega, @V_{GS}=4.5V, I_D=3.6A$ .
- $R_{DS(ON)} \leq 43\text{ m}\Omega, @V_{GS}=2.5V, I_D=2.4A$ .
- Super high dense cell trench design for low on-resistance.
- Rugged and reliable.
- Lead-free parts meet RoHS requirements.
- Halogen-free (IEC61249-2-21).

### Mechanical data

- Epoxy:UL94-V0 rated flame retardant.
- Case : Molded plastic, SOT-23.
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026.
- Weight : Approximated 11mg

### Package outline



### Maximum ratings (At $T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Ratings	Units
Drain-source voltage	$V_{DS}$	30	V
Gate-source voltage	$V_{GS}$	$\pm 12$	V
Continuous drain current (Note 1)	$I_D$	5.2	A
Pulsed drain current (Note 2)	$I_{DM}$	22	A
Drain-source diode forward current (Note 1)	$I_S$	2.5	A
Power dissipation (Note 1)	$P_D$	1.25 0.75	W
Thermal resistance, junction to ambient (Note 1)	$R_{\theta JA}$	100	$^\circ\text{C/W}$
Operation junction temperature	$T_J$	+150	$^\circ\text{C}$
Storage temperature range	$T_{STG}$	-55 to +150	$^\circ\text{C}$

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Electrical characteristics (At  $T_A=25^\circ\text{C}$  unless otherwise noted)

Parameter	Condition	Symbol	Min	Typ	Max	Units
<b>Off characteristics</b>						
Drain-source breakdown voltage	$V_{GS}=0\text{V}, I_D=250\text{A}$	$BV_{DSS}$	30			V
Zero gate voltage drain current	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$	$I_{DSS}$			1	$\mu\text{A}$
Gate-body leakage current	$V_{GS}=\pm 12\text{V}, V_{DS}=0\text{V}$	$I_{GSS}$			$\pm 100$	nA

**On characteristics** (Note3)

Gate threshold voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	$V_{GS(th)}$	0.6	0.9	1.4	V
Drain-source on-state resistance	$V_{GS}=10\text{V}, I_D=5.2\text{A}$	$R_{DS(on)}$		24	32	m $\Omega$
	$V_{GS}=4.5\text{V}, I_D=3.6\text{A}$			26	38	
	$V_{GS}=2.5\text{V}, I_D=2.4\text{A}$			32	43	
Forward transconductance	$V_{GS}=5\text{V}, I_D=5\text{A}$	$g_{FS}$		12		S

**Dynamic parameters** (Note4)

Input capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1.0\text{MHz}$	$C_{iss}$		681		pF
Output capacitance		$C_{oss}$		62		
Reverse transfer capacitance		$C_{rss}$		39		

**Switching parameters** (Note4)

Total gate charge	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=3\text{A}$	$Q_g$		14.5		nC
Gate-source charge		$Q_{gs}$		3.1		
Gate-drain charge		$Q_{gd}$		2.2		
Turn-on delay time	$V_{DD}=15\text{V}, I_D=1\text{A}, V_{GEN}=10\text{V}, R_L=15\Omega, R_{GEN}=6\Omega$	$t_{d(on)}$		7.2		ns
Turn-on rise time		$t_r$		3.0		
Turn-off delay time		$t_{d(off)}$		27.5		
Turn-off fall time		$t_f$		4.1		

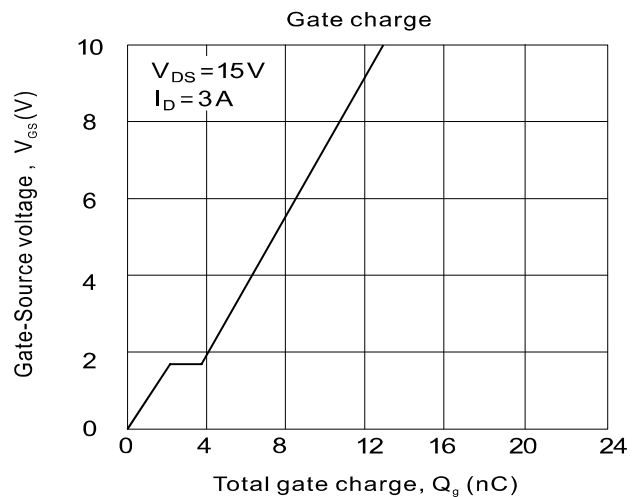
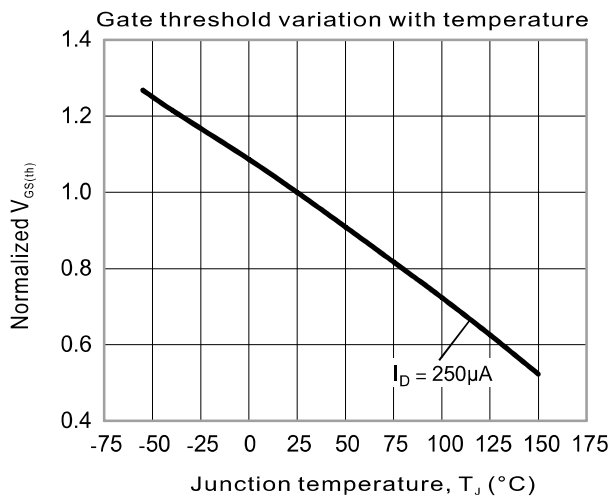
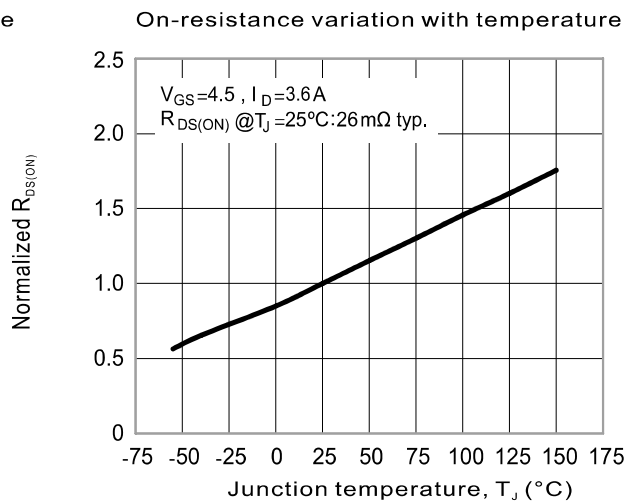
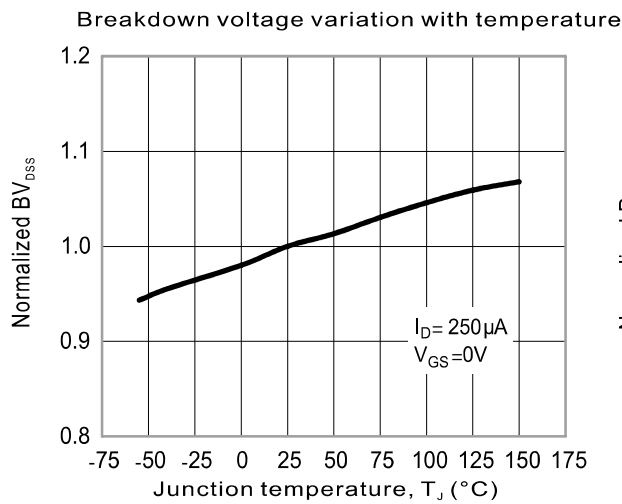
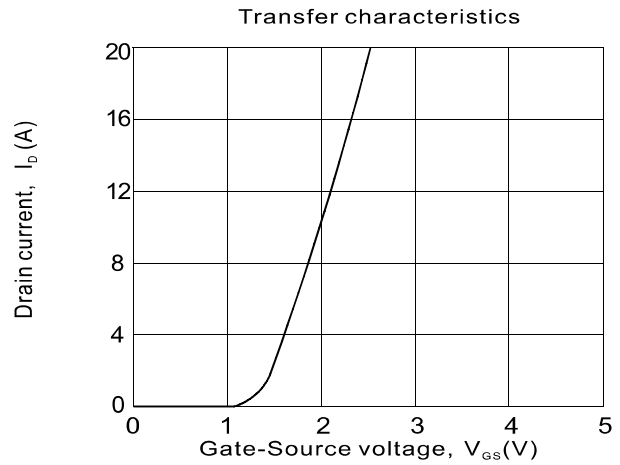
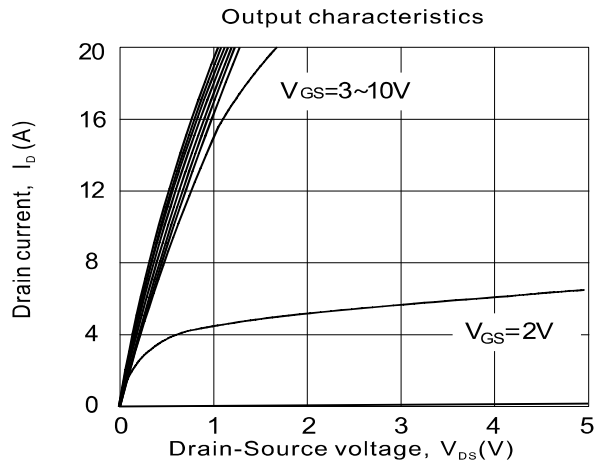
**Source-drain diode ratings and characteristics**

Drain-source diode forward voltage (Note 3)	$I_S=1\text{A}, V_{GS}=0\text{V}$	$V_{SD}$			1.2	V
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- Note: 1. Surface mounted on FR4 board,  $t \leq 10$  seconds.  
 2. Pulse width limited by maximum junction temperature.  
 2. Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .  
 3. Guaranteed by design, not subject to production testing.

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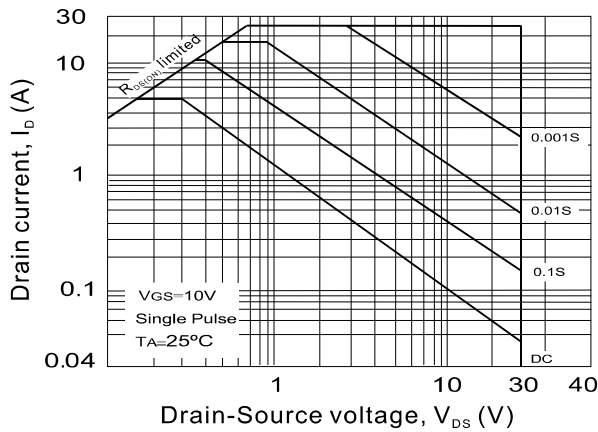
## Rating and characteristic curves



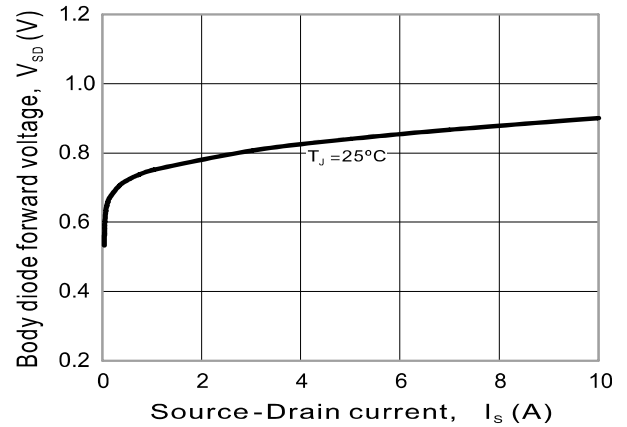
# FMNN3400-H

## Rating and characteristic curves

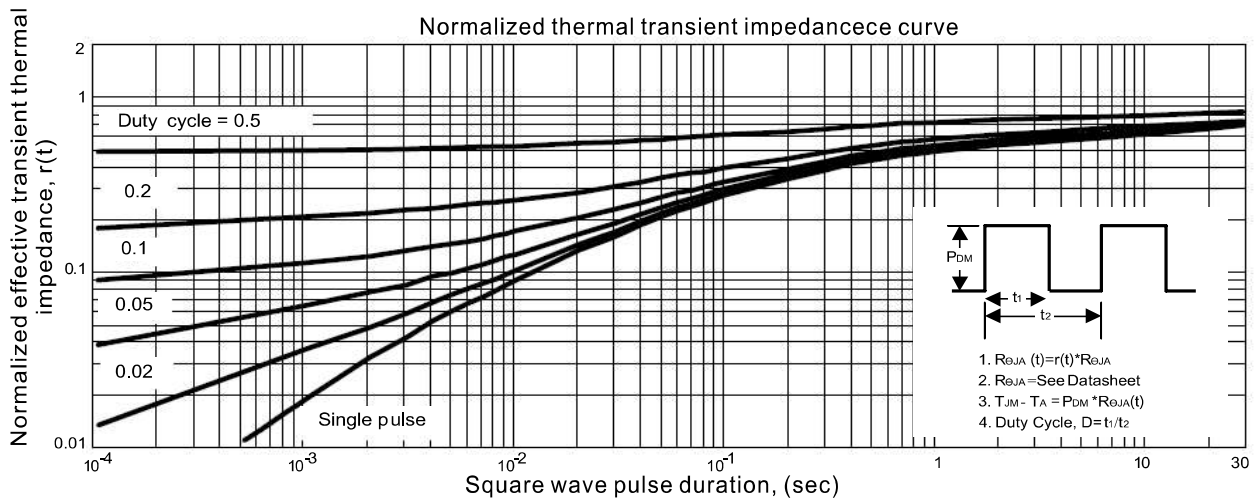
Maximum safe operating area



Body diode forward voltage variation with source current

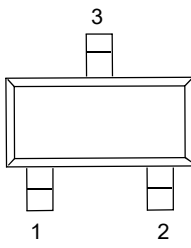
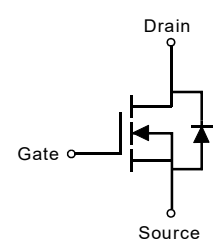


Normalized thermal transient impedance curve



# FMNN3400-H

## Pinning information

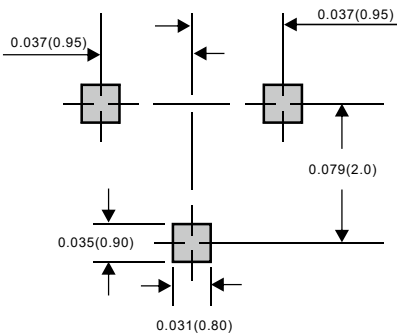
Pin	Simplified outline	Symbol
Pin 1 Gate Pin 2 Source Pin 3 Drain		

## Marking

Type number	Marking code
FMNN3400-H	3400C

## Suggested solder pad layout

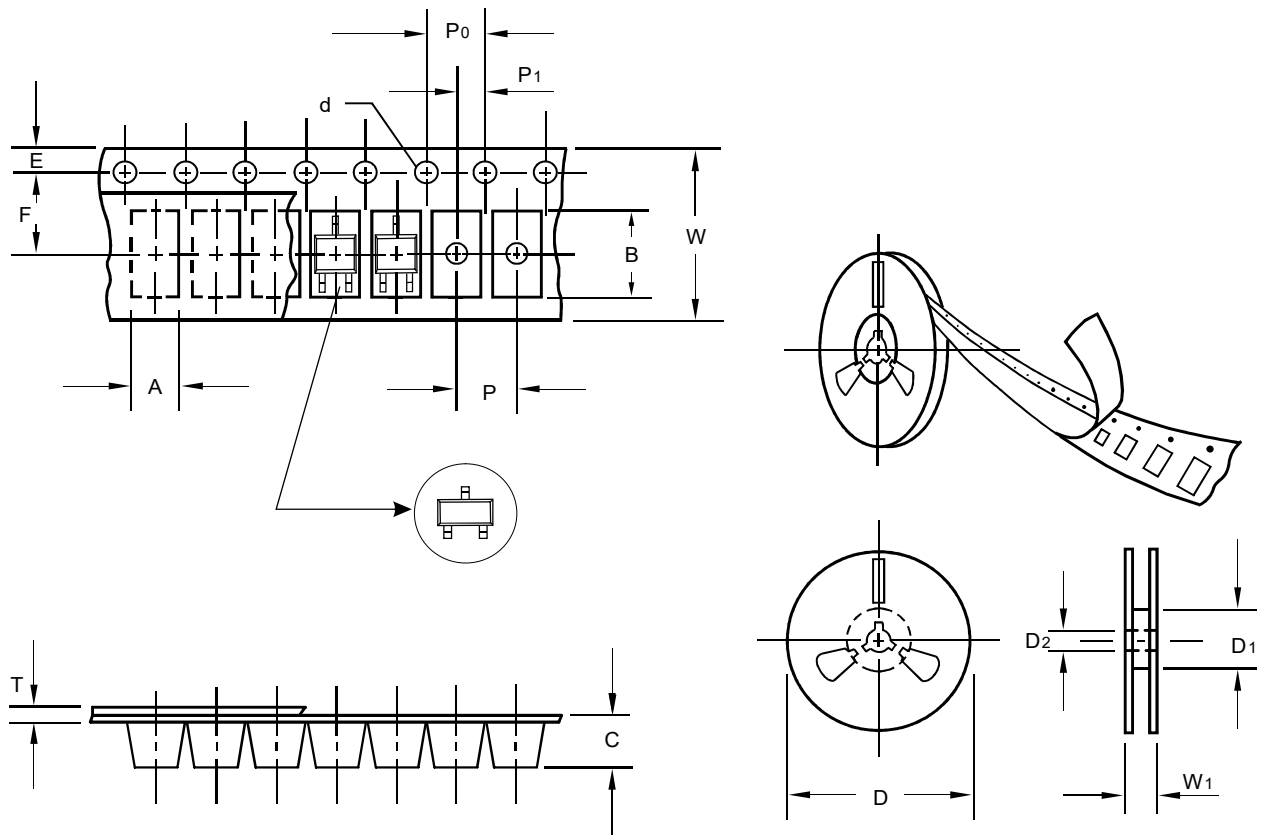
SOT-23



Dimensions in inches and (millimeters)

# FMNN3400-H

## Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.3	3.15
Carrier length	B	0.3	2.77
Carrier depth	C	0.3	1.22
Sprocket hole	d	0.3	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	54.40
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.3	0.23
Tape width	W	0.3	8.00
Reel width	W1	3.0	12.3

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

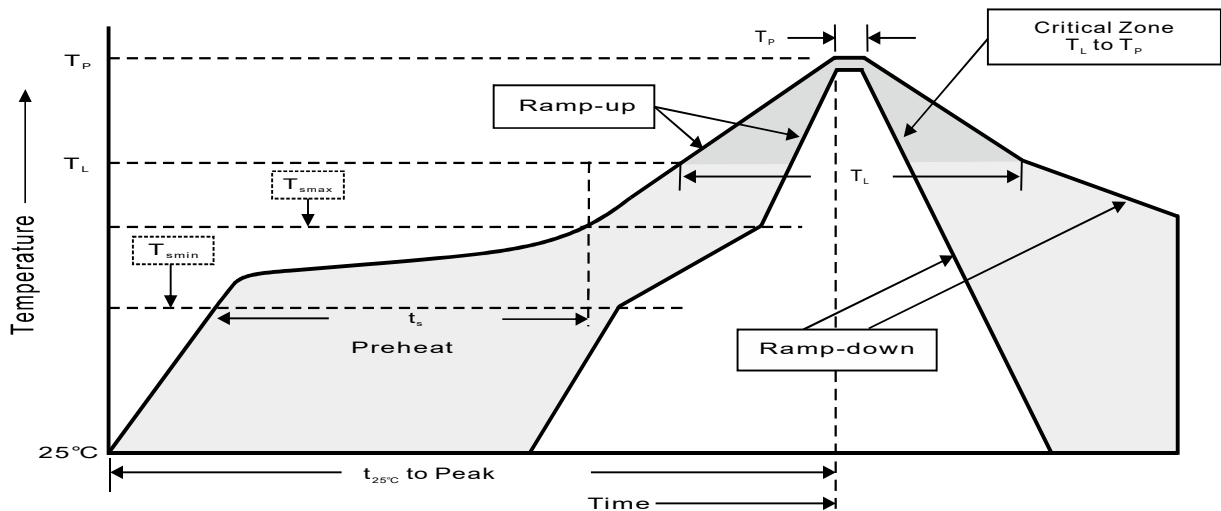
# FMNN3400-H

## Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)
SOT-23	7"	3,000	4.0	30,000	183*123*183	178	382*257*387	240,000

## Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature = 5°C ~ 40°C Humidity = 55%, ±25%
- 2.Reflow soldering of surface-mount devices



### 3.Reflow soldering

Profile feature	Soldering condition
Average ramp-up rate ( $T_L$ to $T_p$ )	< 3 °C/sec
Preheat - Temperature Min ( $T_{smin}$ ) - Temperature Max ( $T_{smax}$ ) - Time (Min to Max) ( $t_s$ )	150°C 200°C 60 ~ 120 sec
$T_{smax}$ to $T_L$ - Ramp-up rate	< 3 °C/sec
Time maintained above : - Temperature ( $T_L$ ) - Time ( $T_L$ )	217°C 60 ~ 260 sec
Peak temperature ( $T_p$ )	255 °C -0/+5°C
Time with 5°C of actual peak temperature ( $T_p$ )	10 ~30 sec
Ramp-down rate	< 6 °C/sec
Time 25°C to peak temperature	< 6 minutes